Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,824	BECK ET AL.	
Examiner	Art Unit	
Tianjie Chen	2652	

SEARCHED				
Class	Subclass	Date	Examiner	
360	122			
	119			
	120			
	121			
	126			
	127	•	•	
	57			
	243.3			
29	603.1			
264	51	10/28/2005	TJ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	L			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Reports	10/28/2005	FJ.		
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